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Article

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Enhanced bulk photovoltaic effect in two-dimensional ferroelectric CuInP_2S_6

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Abstract: The photocurrent generation in photovoltaics relies essentially on the interface of p-n junction or Schottky barrier with the photoelectric efficiency constrained by the Shockley-Queisser limit. The recent progresses have shown a promising route to surpass this limit via the bulk photovoltaic effect (BPVE) for crystals without inversion symmetry. Here we report the BPVE in two-dimensional (2D) ferroelectric CuInP_2S_6 with enhanced photocurrent density by two orders of magnitude higher than conventional bulk ferroelectric perovskite oxides. The BPVE is inherently associated to the room-temperature polar ordering in 2D CuInP_2S_6 . We also demonstrate a crossover from 2D to 3D BPVE material with the observation of a dramatic decrease in photocurrent density when the thickness of the 2D material exceeds the free path length (l_0) at around 40 nm. This work spotlights the potential

application of ultrathin 2D ferroelectric materials for the third-generation photovoltaic cells.

Keywords

Two-dimensional ferroelectrics, CuInP_2S_6 , bulk photovoltaic effect, photoferroics

Introduction

The bulk photovoltaic effect (BPVE), a kind of nonlinear optical process that converts light into electricity in solids, has potential advantage in solar cell with efficiency exceeds the fundamental Shockley-Queisser (S-Q) limit¹⁻⁶. This effect is only valid in crystals with broken inversion symmetry, which can lead to significant electronic polarization⁷⁻⁹ that plays the similar role as the p-n junction and Schottky barrier in photovoltaics. Thus a strong zero-bias photocurrent (or shift current) can be observed in noncentrosymmetric materials when irradiated with light above the energy bandgap¹⁰⁻¹¹. The BPVE is particularly pronounced in polar materials¹²⁻¹⁴. The recent advances of the BPVE in ferroelectric perovskite oxides exceeding the S-Q limit has spurred further exploration for electronic systems with optimal device efficiency performance¹⁵. Along this line the low dimensional materials such as CuInP_2S_6 , $\alpha\text{-In}_2\text{Se}_3$, and MoTe_2 with layered van der Waals (vdW) structure without inversion symmetry have been suggested for high-efficiency photocurrent collection via BPVE¹⁶⁻²⁰. However, while the intriguing physics in the two-dimensional (2D) limit, such as magnetism²¹⁻²³, hyperferroelectricity²⁴⁻²⁷, and exotic topological phases²⁸⁻³⁰ have been widely explored, the direct experimental study on BPVE in 2D materials remains unimplemented.

Here we demonstrate the enhanced BPVE in ultrathin ferroelectric CuInP_2S_6 (CIPS). For the first time, the shift current is directly measured in the family of 2D materials. The enhanced BPVE is associated to the room-temperature ferroelectricity of CuInP_2S_6 as evidenced by the electric polarization, temperature, and thickness dependent behavior. Below the critical temperature $T_c \sim 315 \text{ K}$ ^{16,47} for transition from ferroelectric phase to paraelectric phase, large open-circuit photovoltage (V_{oc}) and short-circuit photocurrent (I_{sc}) are observed along the direction of electric polarization when

irradiated with light. The V_{oc} and I_{sc} can be controlled and even reversed by an external electric field. Based on this approach, the maximum V_{oc} is obtained to be about 1.0 V and the enhanced photocurrent density is two orders of magnitude higher than that reported from the ferroelectric perovskite oxides³¹⁻³⁵. Notably, above T_c , negligible photovoltage and photocurrent are observed in all devices in the paraelectric phase with restored high symmetry³⁶. We find that the shift current density from 2D CIPS falls between that from one-dimensional (1D) and three-dimensional (3D) BPVE based photovoltaics. We also demonstrate a crossover from 2D to 3D photovoltaics when the thickness of the CIPS exceeds the free path length of photocarriers, beyond which the photocurrent reduces to the dark condition level even with inversion symmetry. These results highlight the potential of developing next generation solar cells with ultrathin 2D materials.

Results and discussions

In previous investigations of the BPVE on bulk materials, a capacitor-like structure is utilized (see Fig. 1a), where the dielectric layer or polar material is sandwiched by the top and bottom metal electrodes^{31-32, 35}. When it is irradiated with light, a non-zero I_{sc} could be observed even without external bias. This zero-bias photocurrent is regarded as the characteristic feature of BPVE. The BPVE has been mostly demonstrated in perovskite oxides in the name of photoferroics³. For example, a giant photovoltage above the bandgap was observed in domain engineered BiFeO₃^{3,5}, and the power conversion efficiency possibly above the S-Q limit was reported¹⁵. In these experiments, the sample thickness is much larger than the free path length of hot photocarriers, which is about 10 - 100 nm in a rough estimation^{32, 39}. In 1D nanotube with large free path length, the photocurrent can be furtherly enhanced. Therefore, ultrathin vdW ferroelectrics with controllable thickness are ideal candidates for enhanced photocurrent generation via BPVE (see Fig. 1a).

In this work, 2D CIPS was utilized as the photoferroic layer for BPVE study. The CIPS is an ionic ferroelectrics, where the Cu, In, and paired P-P atoms fill in the sulfur cages. The off-center shift of the Cu cations leads to stable out-of-plane

ferroelectricity^{16,40}. The electrically switchable polarization in CIPS has been demonstrated at room temperature down to thickness of 4 nm¹⁶. Fig. 1b presents the optical image of the 2D photovoltaic device with a sandwiched structure (for device #1). All the ultrathin vdW materials used in the devices were prepared by mechanical exfoliation method⁴¹ and assembled via the dry-transfer technique⁴² (see the detailed fabrication process in Methods). The ultrathin CIPS with thickness down to 8 nm was confirmed by the atomic force microscopy (AFM) and the Raman spectroscopy (see Fig. S1) and their ferroelectricity was confirmed by the piezoresponse force microscopy (PFM) measurement at ambient condition (see Fig. S2). In the device, bilayer and few layer graphene were used as crossed bottom and top electrodes respectively. Benefited from the outstanding optical transmission of graphene in the visible range⁴³⁻⁴⁴, our device is allowed to carry out the direct measurements on photo-generated carriers with the synchronous electric control of the polarization.

The CIPS is a semiconductor with gap width E_g at ~ 2.9 eV⁴⁵⁻⁴⁶, thus to realize the BPVE, the laser with wavelength of 405 nm is chosen as the excitation source. We scan the laser spot (with diameter at 2 μ m, see Methods) over the device at its initial state. From the I_{sc} mapping, we find that the photo-generated current exists only in the overlapping area of the top and bottom graphene electrodes as evidenced by the spatial correspondence (see Fig. 1b - 1c). In contrast, outside the overlapping sandwich area, the photocurrent is negligible at around 2 pA, which is to the level of the background current as limited by the DC source-monitor (see Methods). To check the spatial dependence of I_{sc} in details, we extracted one line-profile from the I_{sc} mapping (see Fig. S3). When the laser spot is moved away from the sandwich edge with step resolution at 160 nm, the I_{sc} vanishes quickly to the noise level. This spatial confinement feature is a direct manifestation of finite free path length of the hot photocarriers. This feature excludes the origin of I_{sc} from Schottky barrier at the single or double graphene/CIPS interfaces. Moreover, the sign and magnitude of the photocurrent are non-uniformly distributed, showing independence on sample topography (see Fig. 1c and Fig. S3). Since the device is not electrically polarized in advance, the spatially randomized photocurrent is the result of the spontaneous electric polarization in CIPS (see Fig. S2).

Next we studied the photocurrent generation in CIPS by homogeneous light illumination on the whole device. In the open-circuit condition, we characterize the relation between photocurrent and voltage using¹⁵

$$V_{oc} = \frac{J_{sc}d}{\sigma_{pv} + \sigma_d}, \quad (1)$$

where d is the sample thickness, J_{sc} is the photocurrent density from the total photocurrent I_{sc} divided by the laser spot area, and σ_{pv}, σ_d (with $\sigma_{pv} \gg \sigma_d$) are the conductivity of the photovoltaic current and the dark current, respectively. In theory $\sigma_{pv} = e I_0 \alpha \varphi \omega^{-1} \mu \tau$, where I_0 is the light intensity, α is the absorption coefficient, φ is the quantum yield and μ, τ are the mobility and lifetime of the hot carriers. The photocurrent density is related to the BPVE via the third-rank piezoelectric tensor as $J_{sc} = \alpha g I_0 \propto I_0$. This relation can be understood from two different aspects by defining the equivalent resistance $R = d/(\sigma_{pv} + \sigma_d)$ and built-in photovoltaic electric field $E_{pv} = J_{sc}/(\sigma_{pv} + \sigma_d)$. Intuitively, a device with high efficiency is required to have large equivalence resistance R and large photovoltaic field E_{pv} , which are essential for photocurrent generation instead of electron-hole recombination. Thus the larger the photovoltaic field is, the stronger photovoltaic voltage it will be. Fig. 2a shows the characteristic output I-V curve from one typical device (device #2). Due to the atomically thin thickness of 2D ferroelectrics, the bias in the DC measurement is set to be within ± 0.1 V (much smaller than V_{oc}), which is equivalent to a field strength of $E_m \sim 10^5$ V/cm, to avoid the degradation of electric polarization in ultrathin CIPS. With light illumination, a large and positive I_{sc} was observed. Using the laser spot area $\sim 20 \text{ um}^2$, we estimate the short-circuit current density J_{sc} to be around 10 mA/cm^2 . In contrast, when the laser is switched off (dark condition), the current density at 0.1 V is about $1 \text{ }\mu\text{A/cm}^2 \ll J_{sc}$. With a linear fit on the output characteristic I-V curve, the V_{oc} is estimated to be -0.8 V, which is close to the coercive field of CIPS (see Fig. S2). Compared with previously reported bulk ferroelectric photovoltaic cells³¹⁻³³, this result yields much larger I_{sc} and V_{oc} at the same excitation density (12.8 W/cm^2). These data yield photoconductivity at the order of $8.7 \times 10^{-7} \text{ S/m}$, which is comparable with the

results reported in literatures³¹⁻³³. A fully characterization of the ferroelectrics for BPVE is summarized in Table I, highlighting the potential advantages of CIPS for BPVE based photovoltaics.

In ferroelectrics, the electric polarization is nonvolatile and electrically switchable. Therefore, the BPVE of CIPS should be in-principle controllable via an external electric field. To verify the relation between the enhanced photocurrent and the ferroelectricity, we study the photocurrent as a function of poling voltage. Fig. 2b presents the photovoltaic behavior of the device (for device #3) with the pulsed poling voltage varying from +1.8 V to -1.8 V and then backward to +1.8 V. When polarizing the device with +1.8 V, a positive photocurrent is observed within ± 0.1 V reading bias. With -1.8 V poling voltage, the current is modulated to negative. By scanning the polarizing voltage, the sign of the photocurrent can be controlled from negative to positive gradually. The asymmetry of the photocurrent between backward and forward scanning arises from the ferroelectric hysteresis of CIPS. Specifically, the switchable photocurrent is summarized in Fig. 2c, where the BPVE can be enhanced or suppressed subject to the electric polarization state of CIPS. To show the hysteresis behavior more clearly, we extract the J_{sc} at each poling voltage. As shown in Fig. 2d, the J_{sc} follows an obvious hysteresis loop when the poling voltage scans forward and backward. Similarly, the V_{oc} as the function of the poling voltage is shown in Fig. S5.

To furtherly investigate the origin of BPVE in CIPS, we study the BPVE as a function of temperature (T). CIPS is a room temperature ferroelectrics with critical temperature T_c at ~ 315 K⁴⁷. Upon heating the device to be above T_c , the ferroelectric CIPS will transform to the paraelectric phase with restored inversion symmetry, in which the BPVE is forbidden strictly. Fig. 3a shows the open-circuit voltage as a function of temperature, in which the V_{oc} decreases with the increasing of temperature and vanishes completely when $T > 315$ K. The disappearance of the photovoltage above T_c indicates that the observed enhanced BPVE is associated to the ferroelectricity of 2D CIPS. We also investigate the photocurrent dependence on light illumination power P_{in} . Fig. 3b displays the J_{sc} and the corresponding σ_{pv} from Eq. 1 as a function of the laser power (for device #2) changing from 1 W/cm² to 20 W/cm². The monotonical increase of

generated J_{sc} with P_{in} is consistent with the prediction of Eq. 1 and the results in previous studies of BPVE^{20, 31-32}. By the extracted open-circuit voltage, we also extract σ_{pv} , which is proportional to the excitation power as expected from Eq. 1. By comparing the photoconductivity of CIPS with that from previous literatures³¹⁻³⁵, we find comparable results in our devices. Importantly, noting that in all the experiments, our samples have the smallest thickness with the similar amplitude of V_{oc} and σ_{pv} , thus the CIPS has the smallest photoconductivity per excitation power if using the data in Table I.

The observed enhanced photocurrent via BPVE in CIPS can be understood through the switchable energy band alignments in the graphene/CIPS/graphene heterostructure. In the ferroelectric phase, the off-center shift of the Cu ions induces a built-in electric field (E_{bi}) perpendicular to the 2D plane. Therefore with an out-of-plane electric polarization, the vacuum levels at the two sides of the CIPS are different as illustrated in Fig. 4a - 4b, which leads to different alignments of the energy bands of graphene at the top and bottom interfaces. The different energy band alignments result in an asymmetric energy potential barrier with barrier height at $\Delta\Phi$ along the out-of-plane direction. For ferroelectric CIPS, the $\Delta\Phi$ could be as large as ~ 1 eV⁴⁸. When the device is illuminated with light, the photo-generated electron and hole pairs are separated by the E_{bi} and are drifted under $\Delta\Phi$ to generate significant I_{sc} . Furthermore, the sign of the asymmetric energy potential barrier between the top and bottom surfaces can be controlled by the direction of electric polarization, leading to the direction switchable photocurrent (Fig. 2c). When the CIPS is with the paraelectric phase, the charged Cu ions are equally distributed at the two surfaces in the unit cell, resulting in a zero E_{bi} and $\Delta\Phi$ as shown in Fig. 4c. There is no observable photocurrent from BPVE.

Finally, to show the advantages of 2D BPVE, we summarize the photocurrent density generated via BPVE from different material systems in Fig. 5a. By considering the linear dependence of the photocurrent on light power density from Eq. 1, we take three colored shadings to represent the performance for 1D, 2D, and 3D BPVE photovoltaics, respectively. We find that the BPVE induced photocurrent density in 2D CIPS falls in the gap between 1D (WS₂ nanotube in Ref. [20]) and conventional 3D ferroelectric

photovoltaics. For 3D materials, most of the ferroelectrics are oxide insulators with perovskite structure, in which the large gap width fundamentally limits the photocurrent density unless via subtle domain engineering (Refs. [3, 5, 6]) or under the aid of scanning probe technique (Ref. [15]). In 1D WS₂ nanotube, the ultrahigh photocurrent density is benefited from the nanoscale diameter size of the tube in nature. The BPVE induced photocurrent density is three orders of magnitude larger than that observed in 3D bulk photovoltaics. However, as confined by the tube structure, the direction of the photocurrent could not be switched by the external electric field. For 2D ferroelectric CIPS, the bulk photovoltaic performance of all the devices (with thickness ranging from 8 nm - 60 nm) fill in this three orders of magnitude gap in J_{sc} . We have also studied 2D CIPS with various thickness (see Fig. 5b), showing that when the thickness is less than $d_c \sim 2l_0$, where $l_0 \sim 40$ nm, significantly enhanced BPVE can be found. In contrast, when the film thickness is larger than the above free path length, the photocurrent decreases to the noise level quickly. This is a clear demonstration of the crossover from 2D to 3D BPVE materials, which has not yet been observed in experiments. Our results suggest that the dimensionality of the photovoltaic materials plays an essential role in photo-electric conversion

Conclusions

We report the enhanced BPVE effect in 2D ferroelectric CIPS. In the ferroelectric phase without inversion symmetry, the photocurrent is enhanced by two orders of magnitude as compared with that in bulk ferroelectric materials. In contrast, in the paraelectric phase with inversion symmetry, the BPVE is absent even in the 2D limit. The performance of our 2D photovoltaics falls in between the 1D and 3D bulk photovoltaics, implying that the device dimensionality is one of the key ingredients for developing high-efficiency BPVE based photovoltaics. From the thickness dependent photocurrent generation, we estimate the free path length in CIPS to be about 40 nm. Our findings highlight the potential of ultrathin 2D ferroelectrics for developing third-generation solar cells with high-efficiency beyond the fundamental S-Q limit.

Methods

Sample Preparation and Topography Measurement: Bulk single crystal graphite and CIPS used in the study were purchased from 2D Semiconductors Inc. The ultrathin vdW materials were prepared by the mechanical exfoliation on Si substrate with 300 nm SiO₂ coated on the top. The vdW heterostructures were made by all-dry transfer technique⁴². The topography and thickness of samples were characterized by atomic force microscopy (AFM) (AIST-Smart SPM) at tapping mode.

Raman spectroscopy characterization: Raman spectra were carried out with the Horiba micro-Raman system (Labran HR Evolution) to verify the phase structure and thickness of CIPS and graphene. The wavelength of the excitation laser is 532 nm and the on-sample power is set to be 150 μ W. As shown in Fig. S1, the characteristic Raman mode of single crystal CIPS at 275 cm⁻¹, 325 cm⁻¹, 384 cm⁻¹ were observed, which confirm the ferroelectric phase and are consistent with previous reports^{16,48}. The graphene thickness is confirmed by the optical contrast under an optical microscope and the Raman spectra. For few layer graphene, the intensity ratio of G mode and 2D mode can be used to identify film thickness. The ratio of I_G/I_{2D} for the bottom graphene electrode in device #1 is 2/3, which confirms that it is bilayer graphene.

PFM characterization: PFM measurements were performed with AIST-Smart SPM system under ambient condition. The PFM tip used is gold coated conducting Si tip. The conductive substrates used in this study were prepared through sputtering 20 nm thick gold film onto Silicon substrate. Ultrathin CIPS was mechanically cleaved directly on the conductive substrate. In the PFM measurements the piezoelectric amplitude and phase show obvious butterfly-like loop and hysteresis loop as shown in Fig. S2 respectively.

Device Fabrication and Transport Measurement: The metal electrodes on the top and bottom graphene were made by the standard UV lithography technique and the following electron beam evaporation of 5 nm Ti and 60 nm Au. The samples were

soaked in acetone 12 hours for the lift-off process. The transport measurement was taken in the vacuum chamber under the pressure blow 0.1 Torr at room temperature and above room temperature. Keysight source meter (B2902A with 100 fA resolution) was used to apply pulsed voltage and measure the I-V characteristics. The excitation laser wavelength for the photovoltaic measurement is 405 nm. The laser was focused on the sample with a home-made scanning confocal microscopy system.

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Author Contributions

H. Z. conceived the idea and supervised the research. Y. L., J. F. and X. M. prepared the samples, fabricated the devices and carried out the photocurrent measurements, H. L. and C. C. carried out the PFM measurements. Y. L., X. M., M. G. and H. Z. analyzed the data and wrote the paper. All authors commented on the manuscript.

Author Information

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Figures and captions

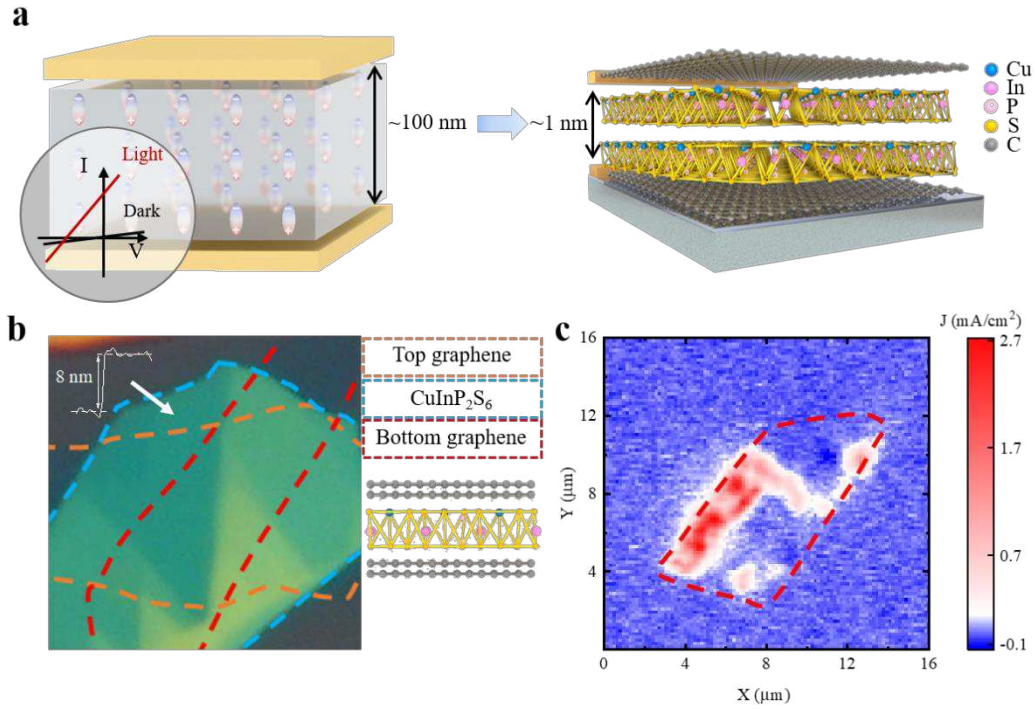


Figure 1. Bulk photovoltaic effect in 2D ferroelectric CIPS. (a) (Left panel) The schematic structure of 3D BPVE device with film thickness at the order of around 100 nm. Inset shows the characteristic I-V curve of bulk photovoltaic effect in 3D ferroelectrics. The black and red lines represent the I-V curves at dark condition and bright condition respectively. (Right panel) The schematic structure of 2D BPVE device. The thickness of 2D ferroelectrics can be as thin as 1 nm. (b) The optical image and (c) corresponding photocurrent density mapping of the 2D BPVE device. The region of top graphene, ultrathin CIPS, and bottom graphene are marked with orange, blue, and red dashed lines respectively.

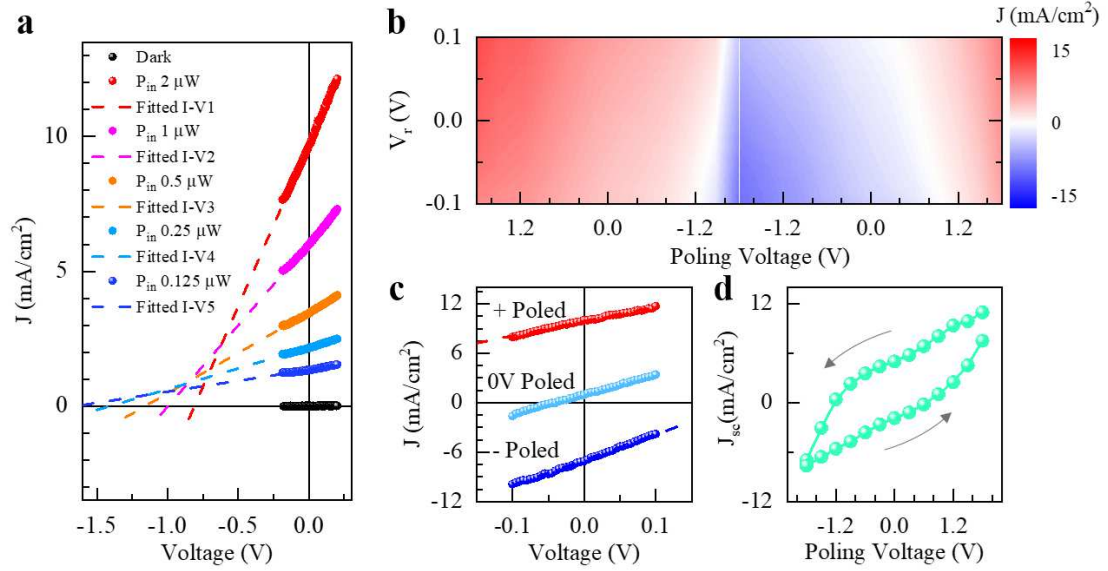


Figure 2. Switchable photovoltaic effect in 2D BPVE device. (a) The characteristic output I-V curves of device #3 at dark (black dots) and bright (color dots) conditions. The excitation light source is the laserline with 405 nm wavelength. The dotted color lines represent the linear fit on the output I-V curves measured at bright condition with different laser power. (b) The photovoltaic behaviour under different poling voltages. The poling voltage is swept from +1.8 V to -1.8 V and then backward to +1.8 V. The reading bias is set to be within ± 0.1 V. The color represents the magnitude of the generated photocurrent density. (c) Extracted output I-V curves at specific poling voltages from Fig. 2b with the red, blue, and dark blue dots representing the positively, zero voltage, and negatively poled states respectively. (d) The plot of I_{sc} as a function of the poling voltage. The arrows indicate the measurement sequence.

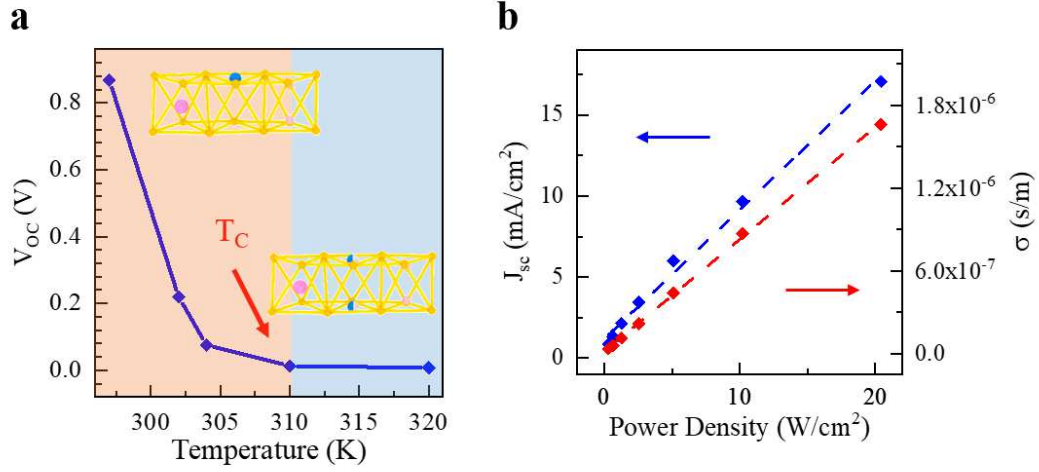


Figure 3. Temperature and power dependence of the BPVE in CIPS. (a) The open-circuit voltage as a function of the temperature. The V_{oc} vanishes when the temperature increases to the phase transition temperature at 315 K. Insets display the crystal structures of CIPS in ferroelectric and paraelectric phases. (b) The short-circuit current density as a function of the illumination power density (left axis) and the photoconductivity (right axis) as a function of the laser power density. Linear dependence of the J_{sc} and σ_{pv} on excitation power is in accord with Eq. 1.

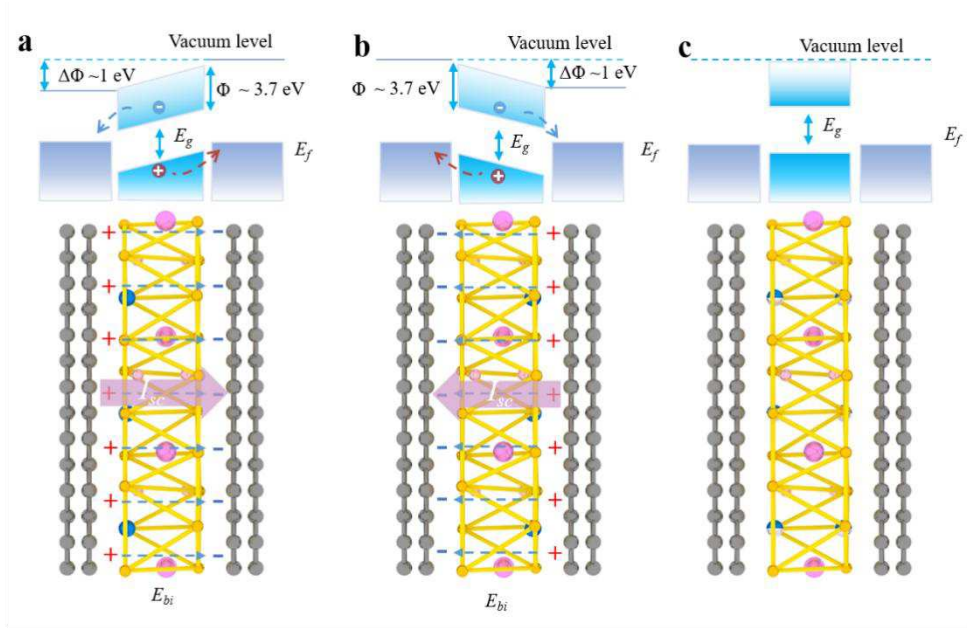


Figure 4. Energy band alignments in the 2D CIPS device. The band diagram for the graphene/CIPS/graphene heterostructure at the upward (a) and downward (b) electric polarization state of ferroelectric CIPS. The top and bottom graphene electrodes are represented with slabs of atoms in grey on the left and right sides of CIPS. In the heterostructure, the polarization charges are marked with “+” and “-” symbols and the build-in electric field are indicated by the dashed lined arrows. The cartoon on the top depicts the corresponding energy shift of the conduction band and valence band. (c) The band diagram of the device with the CIPS at the paraelectric phase.

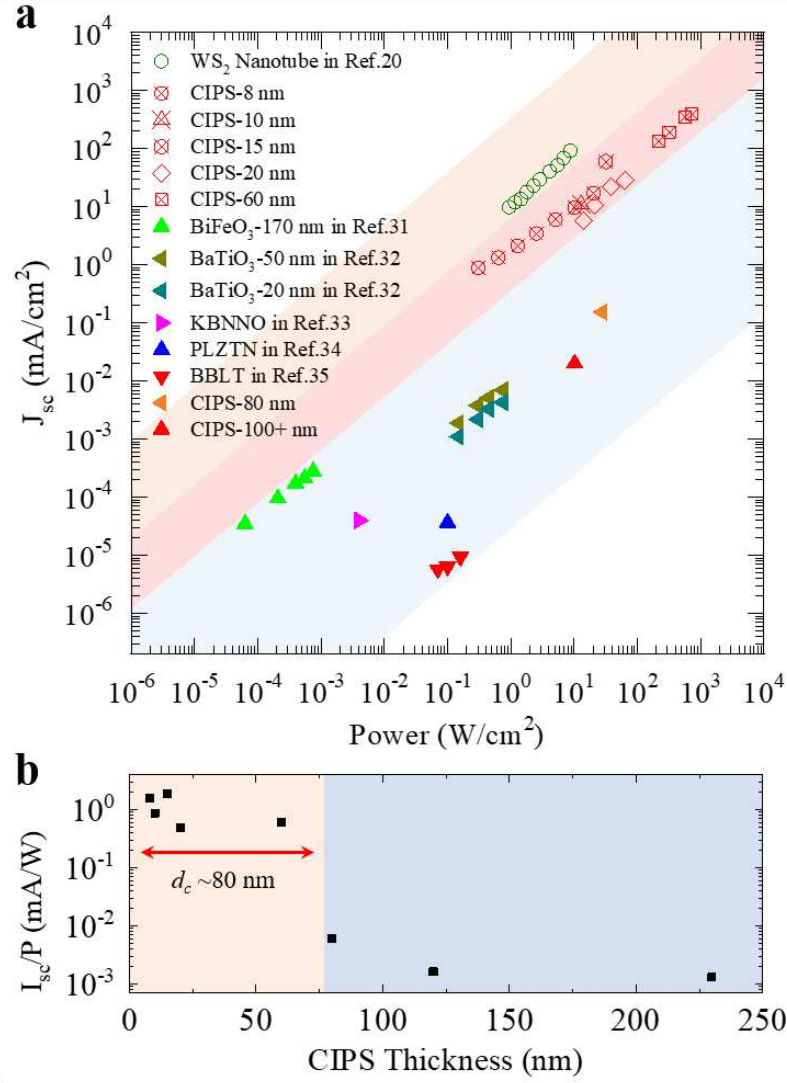


Figure 5. The dimensionality factor of the BPVE. (a) An overview of the photovoltaic performance in 1D, 2D, and 3D BVPE materials. The paralleled polygons filled in yellow, red, and blue represent the short-circuit photocurrent density from 1D, 2D, and 3D bulk photovoltaics respectively. With the same illumination power density, the photocurrent density from 2D ferroelectric CIPS falls in the gap between 1D and 3D bulk photovoltaics. (b) The thickness dependent BPVE in ferroelectric CIPS. For each device with different film thickness, the observed short-circuit photocurrent is normalized by the incident light power. The I_{sc} decreases to the 3D noise level as the CIPS is thicker than 100 nm, indicating of the free path length of the hot photocarriers to be about 40 nm, using the estimation of $d_c \approx 2l_0$.

Table I. The results of short-circuit current density J_{sc} , open-circuit voltage V_{oc} , photoconductivity σ for samples with thickness d and excitation intensity P_{in} . Data in the first eight rows are from previous literature; the last three rows are data from our samples. The photoconductivity per power density can be obtained using σ/P_{in} (not shown), in which the CIPS almost have the smallest conductivity per excitation density.

	J_{sc} (A/cm ²)	V_{oc} (V)	d (nm)	P_{in} (W/cm ²)	σ (S/m)
BTO tip enhanced ^[15]	1.9×10^{-2}	1.2	100	0.1	1.58×10^{-5}
BTO 20 nm ^[32]	2.2×10^{-6}	0.6	20	0.3	7.3×10^{-10}
BTO 50 nm ^[32]	3.8×10^{-6}	0.65	50	0.3	2.92×10^{-9}
BFO ^[31]	3.8×10^{-7}	0.27	170	7.5×10^{-4}	2.39×10^{-9}
KBNNO ^[33]	4×10^{-8}	3.5	2×10^4	4×10^{-3}	2.29×10^{-9}
PLZTN ^[34]	3.67×10^{-8}	23	3×10^5	0.1	4.79×10^{-9}
BBLT ^[35]	6.5×10^{-9}	16	5×10^5	0.1	2.03×10^{-9}
CIPS	9.6×10^{-3}	0.8	7.3	10	8.71×10^{-7}
CIPS	8×10^{-4}	1.75	7.3	0.3	3.3×10^{-8}
CIPS	2.55×10^{-5}	0.5	230	25.5	1.17×10^{-7}

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Figures

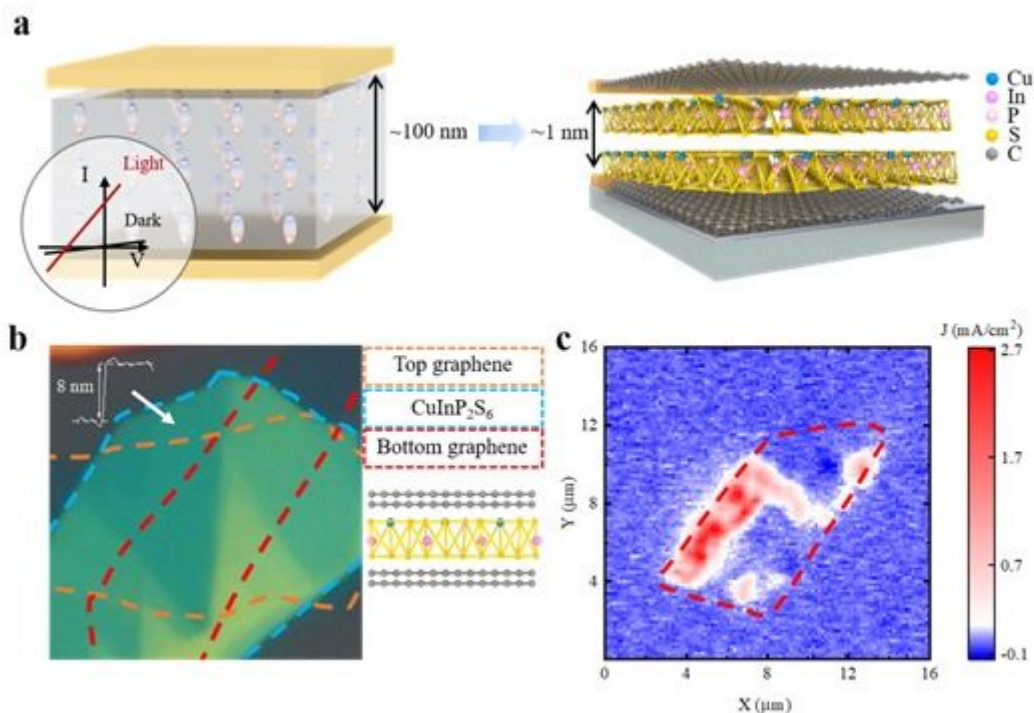


Figure 1

Bulk photovoltaic effect in 2D ferroelectric CIPS. (a) (Left panel) The schematic structure of 3D BPVE device with film thickness at the order of around 100 nm. Inset shows the characteristic I-V curve of bulk photovoltaic effect in 3D ferroelectrics. The black and red lines represent the I-V curves at dark condition and bright condition respectively. (Right panel) The schematic structure of 2D BPVE device. The thickness of 2D ferroelectrics can be as thin as 1 nm. (b) The optical image and (c) corresponding photocurrent density mapping of the 2D BPVE device. The region of top graphene, ultrathin CIPS, and bottom graphene are marked with orange, blue, and red dashed lines respectively.

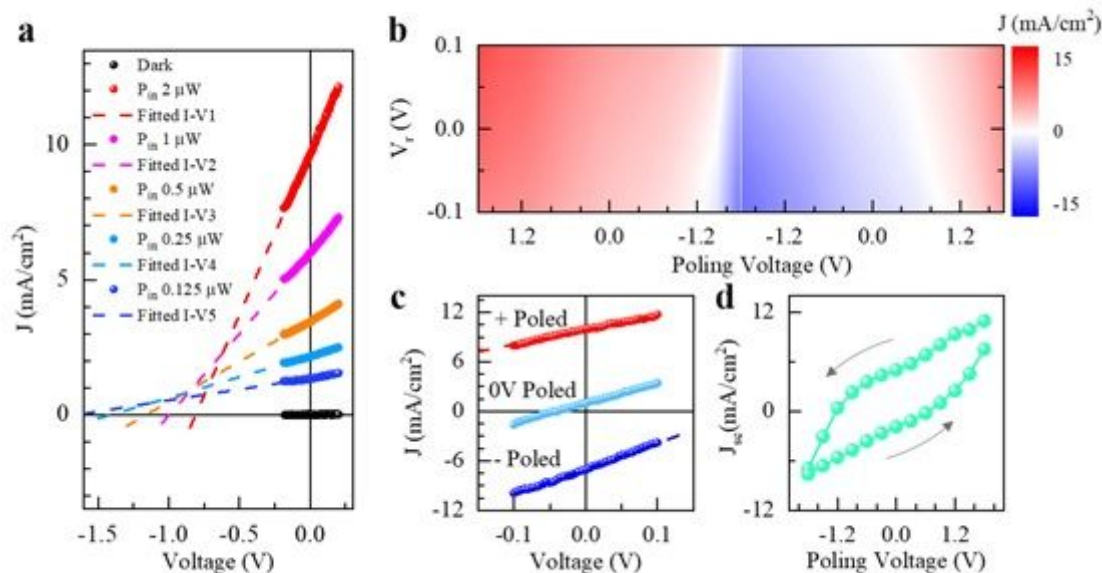


Figure 2

Switchable photovoltaic effect in 2D BPVE device. (a) The characteristic output I-V curves of device #3 at dark (black dots) and bright (color dots) conditions. The excitation light source is the laserline with 405 nm wavelength. The dotted color lines represent the linear fit on the output I-V curves measured at bright condition with different laser power. (b) The photovoltaic behaviour under different poling voltages. The poling voltage is swept from +1.8 V to -1.8 V and then backward to +1.8 V. The reading bias is set to be within ± 0.1 V. The color represents the magnitude of the generated photocurrent density. (c) Extracted output I-V curves at specific poling voltages from Fig. 2b with the red, blue, and dark blue dots representing the positively, zero voltage, and negatively poled states respectively. (d) The plot of J_{sc} as a function of the poling voltage. The arrows indicate the measurement sequence.

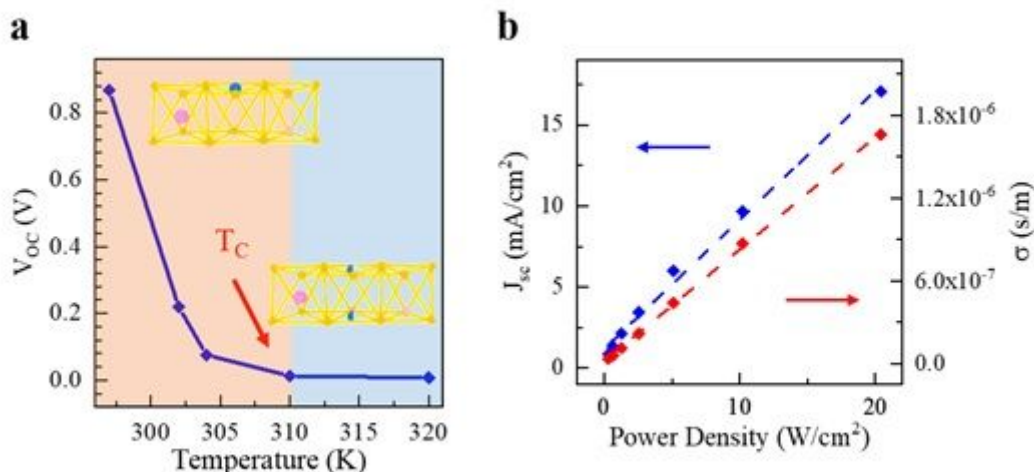


Figure 3

Temperature and power dependence of the BPVE in CIPS. (a) The open-circuit voltage as a function of the temperature. The V_{oc} vanishes when the temperature increases to the phase transition temperature at 315 K. Insets display the crystal structures of CIPS in ferroelectric and paraelectric phases. (b) The short-circuit current density as a function of the illumination power density (left axis) and the photoconductivity (right axis) as a function of the laser power density. Linear dependence of the J_{sc} and σ_{pv} on excitation power is in accord with Eq. 1.

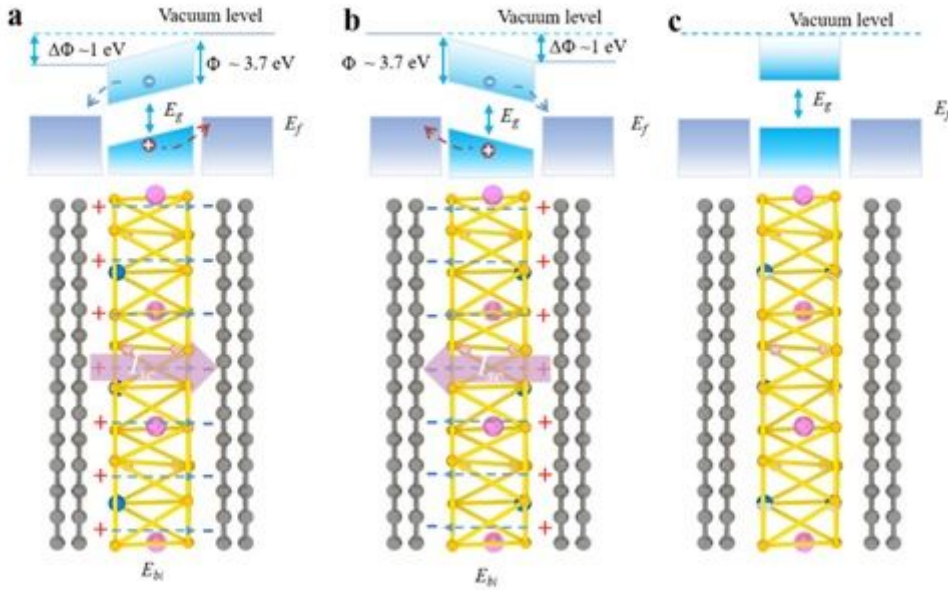


Figure 4

Energy band alignments in the 2D CIPS device. The band diagram for the graphene/CIPS/graphene heterostructure at the upward (a) and downward (b) electric polarization state of ferroelectric CIPS. The top and bottom graphene electrodes are represented with slabs of atoms in grey on the left and right sides of CIPS. In the heterostructure, the polarization charges are marked with "+" and "-" symbols and the built-in electric field are indicated by the dashed lined arrows. The cartoon on the top depicts the corresponding energy shift of the conduction band and valence band. (c) The band diagram of the device with the CIPS at the paraelectric phase.

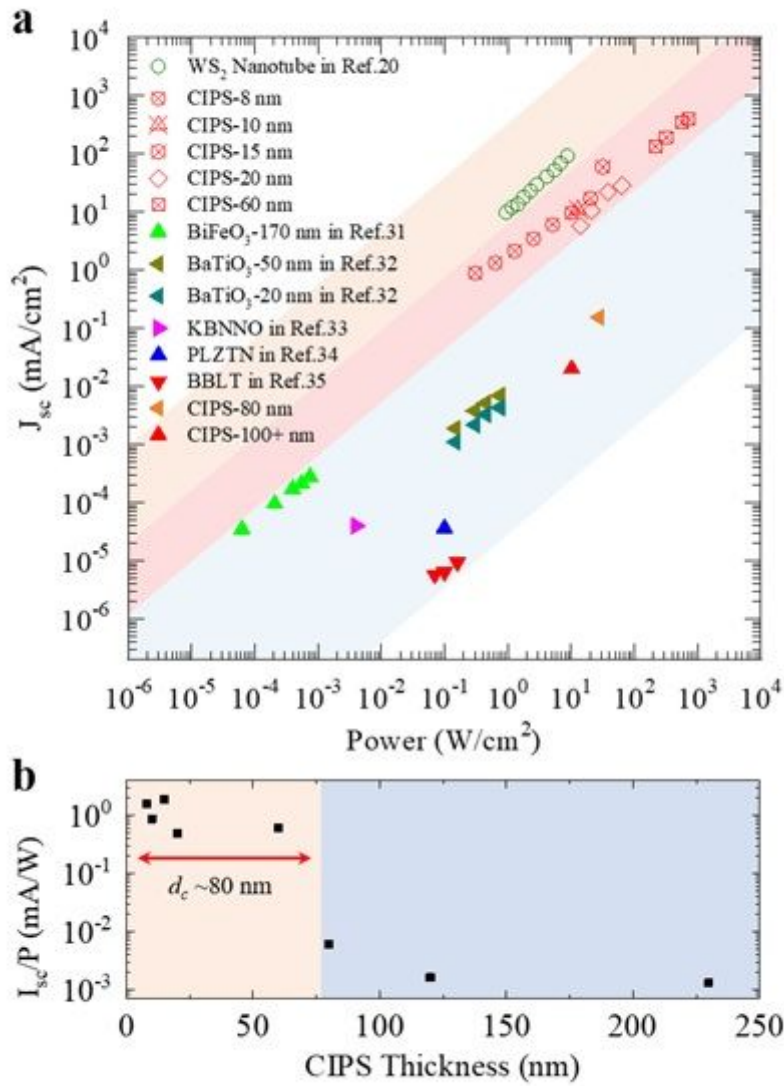


Figure 5

The dimensionality factor of the BPVE. (a) An overview of the photovoltaic performance in 1D, 2D, and 3D BVPE materials. The paralleled polygons filled in yellow, red, and blue represent the short-circuit photocurrent density from 1D, 2D, and 3D bulk photovoltaics respectively. With the same illumination power density, the photocurrent density from 2D ferroelectric CIPS falls in the gap between 1D and 3D bulk photovoltaics. (b) The thickness dependent BPVE in ferroelectric CIPS. For each device with different film thickness, the observed short-circuit photocurrent is normalized by the incident light power. The I_{sc} decreases to the 3D noise level as the CIPS is thicker than 100 nm, indicating of the free path length of the hot photocarriers to be about 40 nm, using the estimation of $d_c \approx 2l_0$.

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